

## IGBT

IGBT with integrated diode in packages offering space saving advantage

### IKD15N60RFA

TRENCHSTOP™ RC-Series for hard switching applications up to 30 kHz

Data sheet

IGBT with integrated diode in packages offering space saving advantage

### Features:

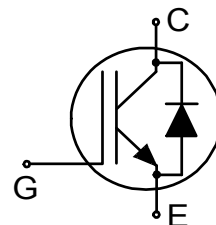
TRENCHSTOP™ Reverse Conducting (RC) technology for 600V applications offering

- Optimized Eon, Eoff and Qrr for low switching losses
- Operating range of 4 to 30kHz
- Smooth switching performance leading to low EMI levels
- Very tight parameter distribution
- Maximum junction temperature 175°C
- Short circuit capability of 5μs
- Best in class current versus package size performance
- Qualified according to AEC-Q101
- Pb-free lead plating; RoHS compliant (solder temperature 260°C, MSL1)

Complete product spectrum and PSpice Models:  
<http://www.infineon.com/igbt/>

### Applications:

- Small drives
- Piezo injection
- Automotive lighting / HID



### Key Performance and Package Parameters

| Type        | $V_{CE}$ | $I_C$ | $V_{CEsat}, T_{vj}=25^{\circ}C$ | $T_{vjmax}$ | Marking | Package    |
|-------------|----------|-------|---------------------------------|-------------|---------|------------|
| IKD15N60RFA | 600V     | 15A   | 2.2V                            | 175°C       | K15DRFA | PG-TO252-3 |

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## Maximum Ratings

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

| Parameter                                                                                                                                                                                                           | Symbol      | Value        | Unit               |
|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------|--------------|--------------------|
| Collector-emitter voltage, $T_{vj} \geq 25^{\circ}\text{C}$                                                                                                                                                         | $V_{CE}$    | 600          | V                  |
| DC collector current, limited by $T_{vjmax}$<br>$T_C = 25^{\circ}\text{C}$<br>$T_C = 100^{\circ}\text{C}$                                                                                                           | $I_C$       | 30.0<br>15.0 | A                  |
| Pulsed collector current, $t_p$ limited by $T_{vjmax}^{1)}$                                                                                                                                                         | $I_{Cpuls}$ | 45.0         | A                  |
| Turn off safe operating area<br>$V_{CE} \leq 600\text{V}$ , $T_{vj} \leq 175^{\circ}\text{C}$ , $t_p = 1\mu\text{s}^{2)}$                                                                                           | -           | 45.0         | A                  |
| Diode forward current, limited by $T_{vjmax}$<br>$T_C = 25^{\circ}\text{C}$<br>$T_C = 100^{\circ}\text{C}$                                                                                                          | $I_F$       | 30.0<br>15.0 | A                  |
| Diode pulsed current, $t_p$ limited by $T_{vjmax}^{1)}$                                                                                                                                                             | $I_{Fpuls}$ | 45.0         | A                  |
| Gate-emitter voltage                                                                                                                                                                                                | $V_{GE}$    | $\pm 20$     | V                  |
| Short circuit withstand time<br>$V_{GE} = 15.0\text{V}$ , $V_{CC} \leq 400\text{V}$<br>Allowed number of short circuits < 1000<br>Time between short circuits: $\geq 1.0\text{s}$<br>$T_{vj} = 150^{\circ}\text{C}$ | $t_{SC}$    | 5            | $\mu\text{s}$      |
| Power dissipation $T_C = 25^{\circ}\text{C}$                                                                                                                                                                        | $P_{tot}$   | 240.0        | W                  |
| Operating junction temperature                                                                                                                                                                                      | $T_{vj}$    | -40...+175   | $^{\circ}\text{C}$ |
| Storage temperature                                                                                                                                                                                                 | $T_{stg}$   | -55...+150   | $^{\circ}\text{C}$ |
| Soldering temperature,<br>reflow soldering (MSL1 according to JEDEC J-STA-020)                                                                                                                                      |             | 260          | $^{\circ}\text{C}$ |

## Thermal Resistance

| Parameter                                                               | Symbol        | Conditions | Max. Value | Unit |
|-------------------------------------------------------------------------|---------------|------------|------------|------|
| <b>Characteristic</b>                                                   |               |            |            |      |
| IGBT thermal resistance, <sup>3)</sup><br>junction - case               | $R_{th(j-c)}$ |            | 0.62       | K/W  |
| Diode thermal resistance, <sup>4)</sup><br>junction - case              | $R_{th(j-c)}$ |            | 2.00       | K/W  |
| Thermal resistance, min. footprint<br>junction - ambient                | $R_{th(j-a)}$ |            | 75         | K/W  |
| Thermal resistance, 6cm <sup>2</sup> Cu on<br>PCB<br>junction - ambient | $R_{th(j-a)}$ |            | 50         | K/W  |

<sup>1)</sup> Defined by design. Not subject to production test.  $I_{Cpulsmax}$  limited by bondwire for  $t_{pmax}=20\text{ms}$ .

<sup>2)</sup> Defined by design. Not subject to production test.

<sup>3)</sup>  $R_{th}/Z_{th}$  based on single cooling pulse. Please be aware that a correct  $R_{th}$  measurement of the IGBT, is not possible using a thermocouple.

<sup>4)</sup>  $R_{th}/Z_{th}$  based on single cooling pulse. Please be aware that a correct  $R_{th}$  measurement of the Diode, is not possible using a thermocouple.

**Electrical Characteristic, at  $T_{vj} = 25^{\circ}\text{C}$ , unless otherwise specified**

| Parameter                            | Symbol        | Conditions                                                                         | Value  |              |           | Unit     |
|--------------------------------------|---------------|------------------------------------------------------------------------------------|--------|--------------|-----------|----------|
|                                      |               |                                                                                    | min.   | typ.         | max.      |          |
| Static Characteristic                |               |                                                                                    |        |              |           |          |
| Collector-emitter breakdown voltage  | $V_{(BR)CES}$ | $V_{GE} = 0V, I_C = 0.20mA$                                                        | 600    | -            | -         | V        |
| Collector-emitter saturation voltage | $V_{CEsat}$   | $V_{GE} = 15.0V, I_C = 15.0A$<br>$T_{vj} = 25^{\circ}C$<br>$T_{vj} = 175^{\circ}C$ | -<br>- | 2.20<br>2.30 | 2.50<br>- | V        |
| Diode forward voltage                | $V_F$         | $V_{GE} = 0V, I_F = 15.0A$<br>$T_{vj} = 25^{\circ}C$<br>$T_{vj} = 175^{\circ}C$    | -<br>- | 2.10<br>2.00 | 2.40<br>- | V        |
| Gate-emitter threshold voltage       | $V_{GE(th)}$  | $I_C = 0.25mA, V_{CE} = V_{GE}$                                                    | 4.3    | 5.0          | 5.7       | V        |
| Zero gate voltage collector current  | $I_{CES}$     | $V_{CE} = 600V, V_{GE} = 0V$<br>$T_{vj} = 25^{\circ}C$<br>$T_{vj} = 175^{\circ}C$  | -<br>- | -<br>650.0   | 40.0<br>- | $\mu A$  |
| Gate-emitter leakage current         | $I_{GES}$     | $V_{CE} = 0V, V_{GE} = 20V$                                                        | -      | -            | 100       | nA       |
| Transconductance <sup>1)</sup>       | $g_{fs}$      | $V_{CE} = 10V, I_C = 15.0A$                                                        | -      | 6.6          | -         | S        |
| Integrated gate resistor             | $r_G$         |                                                                                    |        | none         |           | $\Omega$ |

**Electrical Characteristic, at  $T_{vj} = 25^{\circ}\text{C}$ , unless otherwise specified**

| Parameter                                                                                               | Symbol      | Conditions                                                                            | Value |      |      | Unit |
|---------------------------------------------------------------------------------------------------------|-------------|---------------------------------------------------------------------------------------|-------|------|------|------|
|                                                                                                         |             |                                                                                       | min.  | typ. | max. |      |
| Dynamic Characteristic                                                                                  |             |                                                                                       |       |      |      |      |
| Input capacitance                                                                                       | $C_{ies}$   | $V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$                                                 | -     | 961  | -    | pF   |
| Output capacitance                                                                                      | $C_{oes}$   |                                                                                       | -     | 53   | -    |      |
| Reverse transfer capacitance                                                                            | $C_{res}$   |                                                                                       | -     | 33   | -    |      |
| Gate charge                                                                                             | $Q_G$       | $V_{CC} = 480V, I_C = 15.0A,$<br>$V_{GE} = 15V$                                       | -     | 90.0 | -    | nC   |
| Internal emitter inductance<br>measured 5mm (0.197 in.) from<br>case                                    | $L_E$       |                                                                                       | -     | 7.0  | -    | nH   |
| Short circuit collector current<br>Max. 1000 short circuits<br>Time between short circuits: $\geq 1.0s$ | $I_{C(SC)}$ | $V_{GE} = 15.0V, V_{CC} \leq 400V,$<br>$t_{SC} \leq 5\mu s$<br>$T_{vj} = 25^{\circ}C$ | -     | 112  | -    | A    |

<sup>1)</sup> Typical value of transconductance determined at  $T_{vj}=175^{\circ}\text{C}$ .

**Switching Characteristic, Inductive Load**

| Parameter                                             | Symbol              | Conditions                                                                                                                                                                                                                                                                            | Value |      |      | Unit |
|-------------------------------------------------------|---------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------|------|------|------|
|                                                       |                     |                                                                                                                                                                                                                                                                                       | min.  | typ. | max. |      |
| IGBT Characteristic, at $T_{vj} = 25^{\circ}\text{C}$ |                     |                                                                                                                                                                                                                                                                                       |       |      |      |      |
| Turn-on delay time                                    | $t_{d(\text{on})}$  | $T_{vj} = 25^{\circ}\text{C}$ ,<br>$V_{CC} = 400\text{V}$ , $I_C = 15.0\text{A}$ ,<br>$V_{GE} = 0.0/15.0\text{V}$ ,<br>$R_{G(\text{on})} = 15.0\Omega$ , $R_{G(\text{off})} = 15.0\Omega$ ,<br>$L\sigma = 50\text{nH}$ , $C\sigma = 34\text{pF}$<br>$L\sigma$ , $C\sigma$ from Fig. E | -     | 13   | -    | ns   |
| Rise time                                             | $t_r$               |                                                                                                                                                                                                                                                                                       | -     | 15   | -    | ns   |
| Turn-off delay time                                   | $t_{d(\text{off})}$ |                                                                                                                                                                                                                                                                                       | -     | 160  | -    | ns   |
| Fall time                                             | $t_f$               |                                                                                                                                                                                                                                                                                       | -     | 17   | -    | ns   |
| Turn-on energy                                        | $E_{\text{on}}$     |                                                                                                                                                                                                                                                                                       | -     | 0.27 | -    | mJ   |
| Turn-off energy                                       | $E_{\text{off}}$    |                                                                                                                                                                                                                                                                                       | -     | 0.25 | -    | mJ   |
| Total switching energy                                | $E_{\text{ts}}$     |                                                                                                                                                                                                                                                                                       | -     | 0.52 | -    | mJ   |

**Diode Characteristic, at  $T_{vj} = 25^{\circ}\text{C}$** 

|                                                                  |              |                                                                                                                            |   |      |   |                  |
|------------------------------------------------------------------|--------------|----------------------------------------------------------------------------------------------------------------------------|---|------|---|------------------|
| Diode reverse recovery time                                      | $t_{rr}$     | $T_{vj} = 25^{\circ}\text{C}$ ,<br>$V_R = 400\text{V}$ ,<br>$I_F = 15.0\text{A}$ ,<br>$di_F/dt = 1030\text{A}/\mu\text{s}$ | - | 74   | - | ns               |
| Diode reverse recovery charge                                    | $Q_{rr}$     |                                                                                                                            | - | 0.42 | - | $\mu\text{C}$    |
| Diode peak reverse recovery current                              | $I_{rrm}$    |                                                                                                                            | - | 13.2 | - | A                |
| Diode peak rate of fall of reverse recovery current during $t_b$ | $di_{rr}/dt$ |                                                                                                                            | - | -211 | - | A/ $\mu\text{s}$ |

**Switching Characteristic, Inductive Load**

| Parameter                                              | Symbol              | Conditions                                                                                                                                                                                                                                                                                         | Value |      |      | Unit |
|--------------------------------------------------------|---------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------|------|------|------|
|                                                        |                     |                                                                                                                                                                                                                                                                                                    | min.  | typ. | max. |      |
| IGBT Characteristic, at $T_{vj} = 175^{\circ}\text{C}$ |                     |                                                                                                                                                                                                                                                                                                    |       |      |      |      |
| Turn-on delay time                                     | $t_{d(\text{on})}$  | $T_{vj} = 175^{\circ}\text{C}$ ,<br>$V_{CC} = 400\text{V}$ , $I_C = 15.0\text{A}$ ,<br>$V_{GE} = 0.0/15.0\text{V}$ ,<br>$R_{G(\text{on})} = 15.0\Omega$ , $R_{G(\text{off})} = 15.0\Omega$ ,<br>$L_{\sigma} = 50\text{nH}$ , $C_{\sigma} = 34\text{pF}$<br>$L_{\sigma}$ , $C_{\sigma}$ from Fig. E | -     | 13   | -    | ns   |
| Rise time                                              | $t_r$               |                                                                                                                                                                                                                                                                                                    | -     | 17   | -    | ns   |
| Turn-off delay time                                    | $t_{d(\text{off})}$ |                                                                                                                                                                                                                                                                                                    | -     | 173  | -    | ns   |
| Fall time                                              | $t_f$               |                                                                                                                                                                                                                                                                                                    | -     | 20   | -    | ns   |
| Turn-on energy                                         | $E_{\text{on}}$     |                                                                                                                                                                                                                                                                                                    | -     | 0.45 | -    | mJ   |
| Turn-off energy                                        | $E_{\text{off}}$    |                                                                                                                                                                                                                                                                                                    | -     | 0.33 | -    | mJ   |
| Total switching energy                                 | $E_{\text{ts}}$     |                                                                                                                                                                                                                                                                                                    | -     | 0.78 | -    | mJ   |

**Diode Characteristic, at  $T_{vj} = 175^{\circ}\text{C}$** 

|                                                                  |              |                                                                                                                            |   |      |   |                  |
|------------------------------------------------------------------|--------------|----------------------------------------------------------------------------------------------------------------------------|---|------|---|------------------|
| Diode reverse recovery time                                      | $t_{rr}$     | $T_{vj} = 175^{\circ}\text{C}$ ,<br>$V_R = 400\text{V}$ ,<br>$I_F = 15.0\text{A}$ ,<br>$di_F/dt = 880\text{A}/\mu\text{s}$ | - | 142  | - | ns               |
| Diode reverse recovery charge                                    | $Q_{rr}$     |                                                                                                                            | - | 1.00 | - | $\mu\text{C}$    |
| Diode peak reverse recovery current                              | $I_{rrm}$    |                                                                                                                            | - | 16.6 | - | A                |
| Diode peak rate of fall of reverse recovery current during $t_b$ | $di_{rr}/dt$ |                                                                                                                            | - | -133 | - | A/ $\mu\text{s}$ |

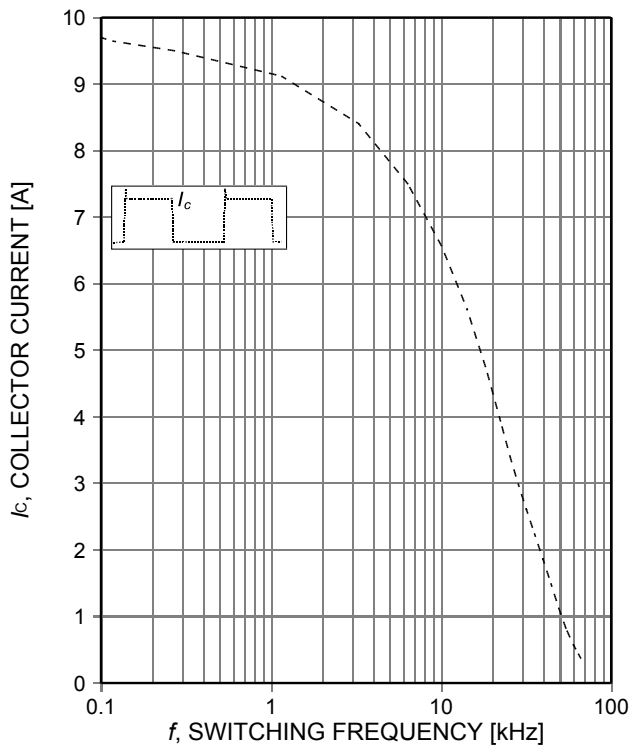


Figure 1. **Collector current as a function of switching frequency**  
 $(T_{vj} \leq 175^\circ\text{C}, T_a = 55^\circ\text{C}, D = 0.5, V_{CE} = 400\text{V}, V_{GE} = 0/15\text{V}, r_G = 15\Omega, \text{PCB mounting with thermal vias and heatsink, see Appnote: } \text{www.infineon.com/igbt})$

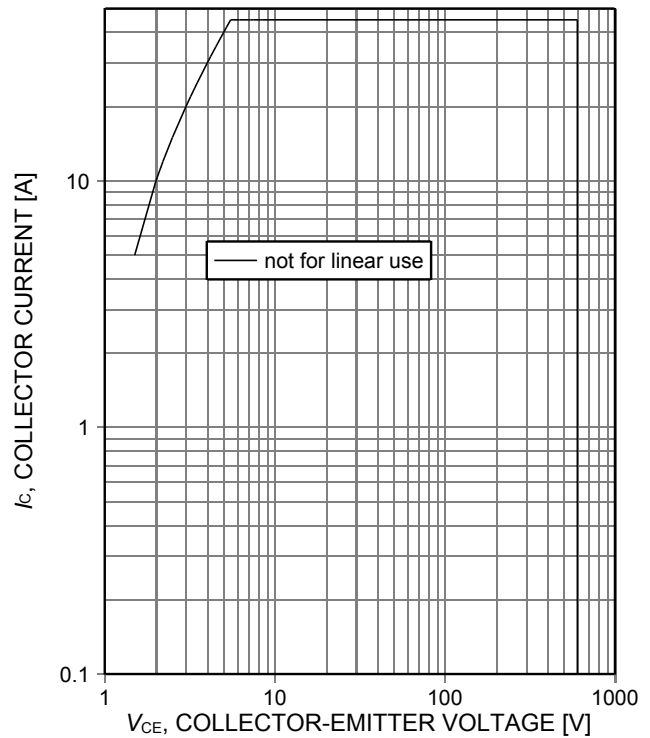


Figure 2. **Forward bias safe operating area**  
 $(D = 0, T_C = 25^\circ\text{C}, T_{vj} \leq 175^\circ\text{C}, V_{GE} = 15\text{V}, t_p = 1\mu\text{s})$

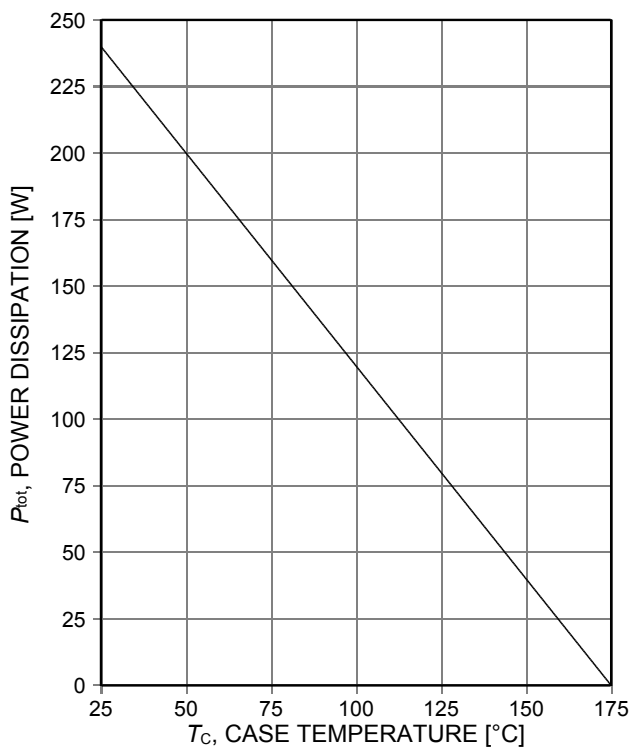


Figure 3. **Power dissipation as a function of case temperature**  
 $(T_{vj} \leq 175^\circ\text{C})$

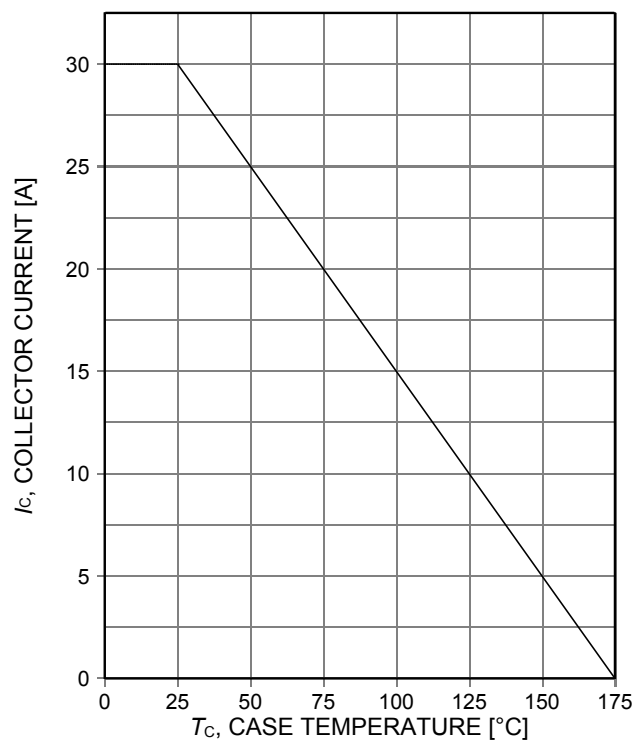


Figure 4. **Collector current as a function of case temperature**  
 $(V_{GE} \geq 15\text{V}, T_{vj} \leq 175^\circ\text{C})$

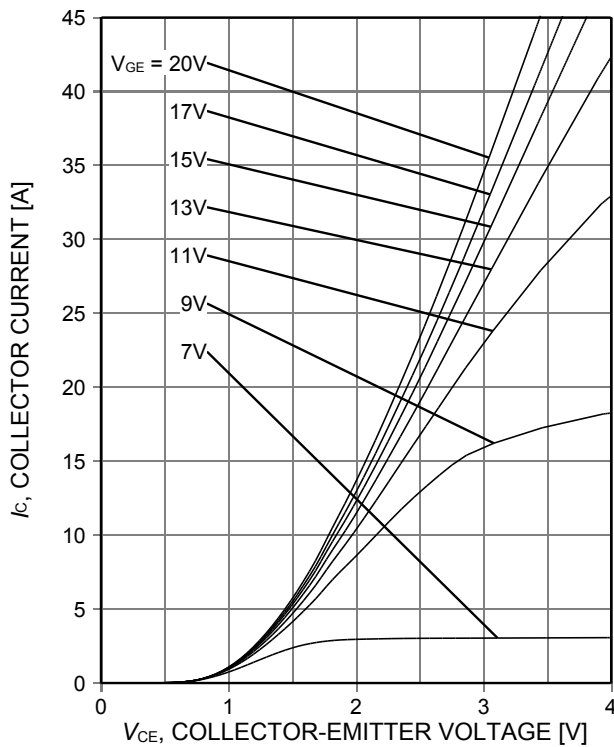


Figure 5. **Typical output characteristic**  
( $T_{vj}=25^{\circ}\text{C}$ )

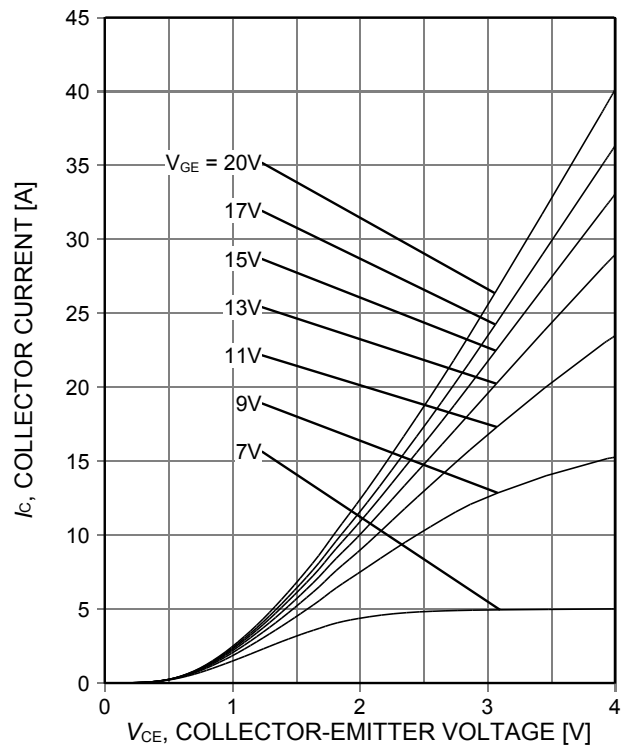


Figure 6. **Typical output characteristic**  
( $T_{vj}=175^{\circ}\text{C}$ )

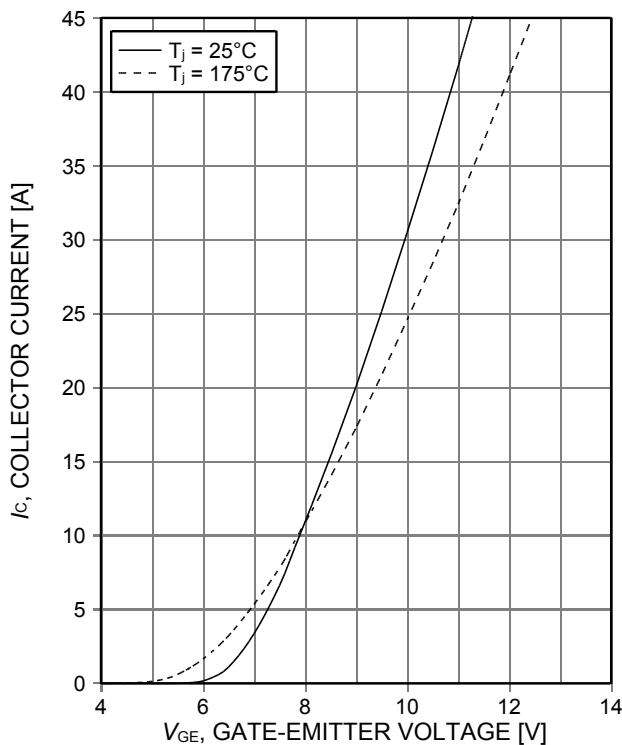


Figure 7. **Typical transfer characteristic**  
( $V_{CE}=10\text{V}$ )

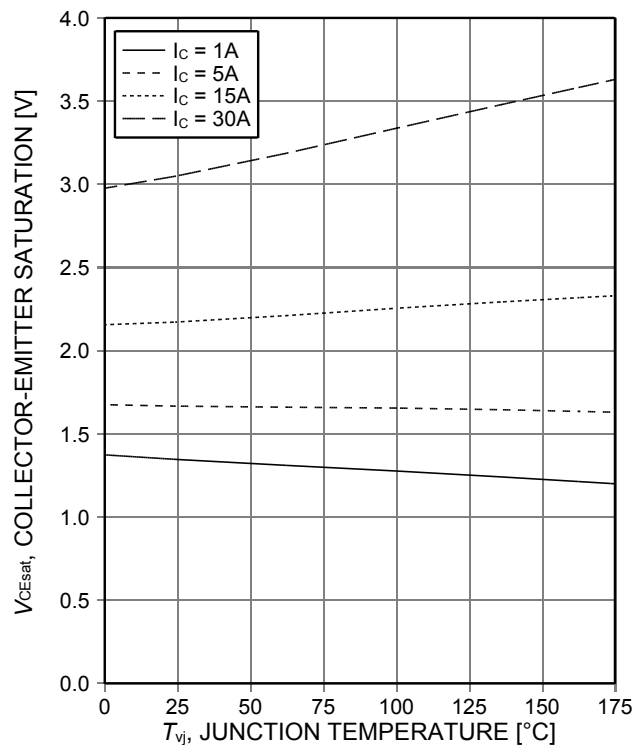


Figure 8. **Typical collector-emitter saturation voltage as a function of junction temperature**  
( $V_{GE}=15\text{V}$ )



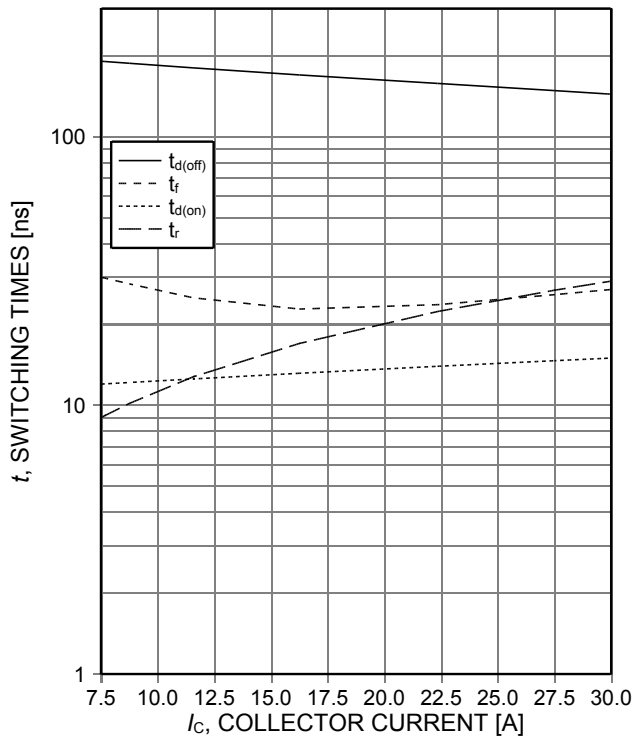


Figure 9. **Typical switching times as a function of collector current**  
(inductive load,  $T_{vj}=175^{\circ}\text{C}$ ,  $V_{CE}=400\text{V}$ ,  $V_{GE}=15/0\text{V}$ ,  $r_G=15\Omega$ , Dynamic test circuit in Figure E)

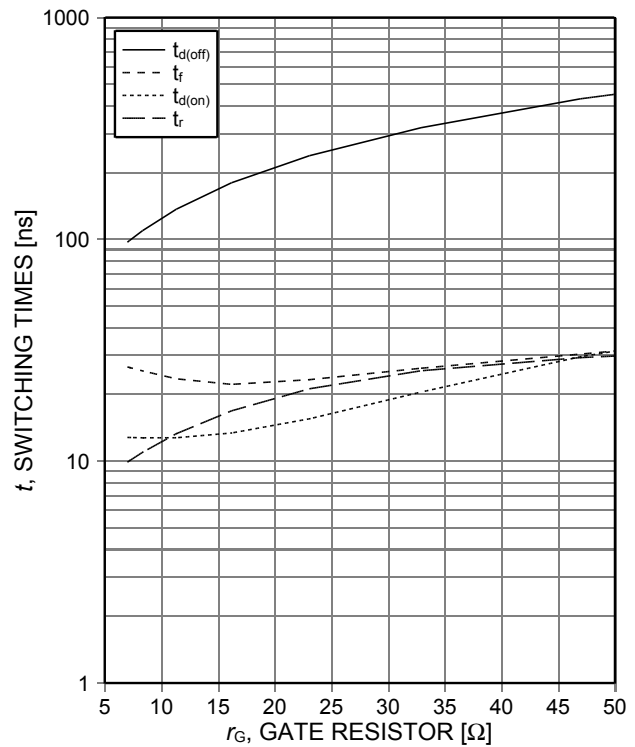


Figure 10. **Typical switching times as a function of gate resistor**  
(inductive load,  $T_{vj}=175^{\circ}\text{C}$ ,  $V_{CE}=400\text{V}$ ,  $V_{GE}=15/0\text{V}$ ,  $I_C=15\text{A}$ , Dynamic test circuit in Figure E)

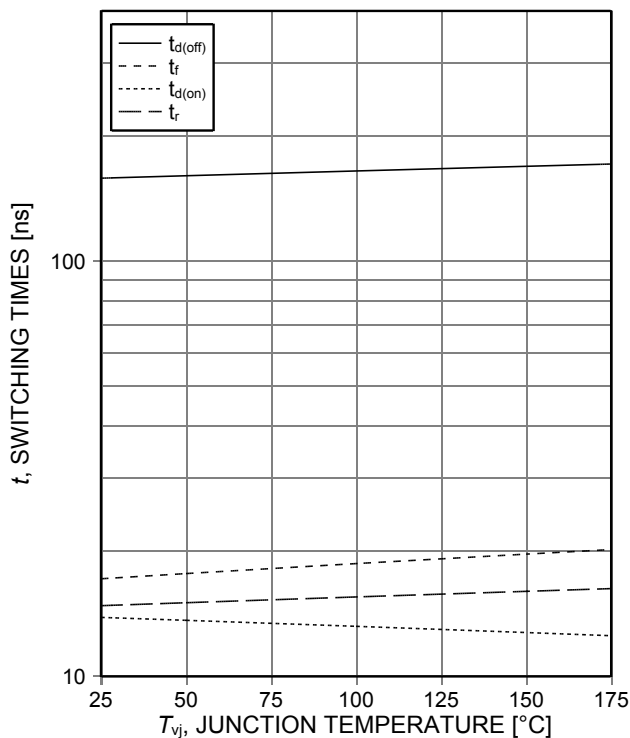


Figure 11. **Typical switching times as a function of junction temperature**  
(inductive load,  $V_{CE}=400\text{V}$ ,  $V_{GE}=15/0\text{V}$ ,  $I_C=15\text{A}$ ,  $r_G=15\Omega$ , Dynamic test circuit in Figure E)

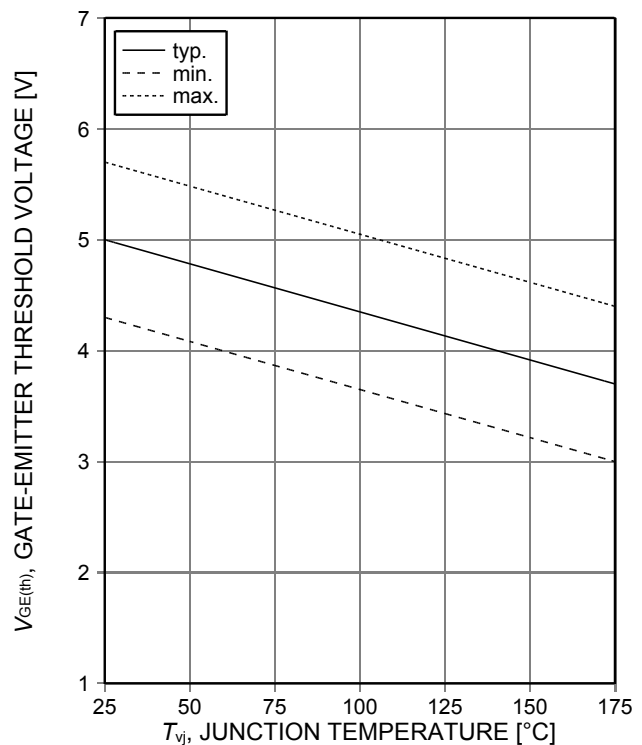


Figure 12. **Gate-emitter threshold voltage as a function of junction temperature**  
( $I_C=0,25\text{mA}$ )

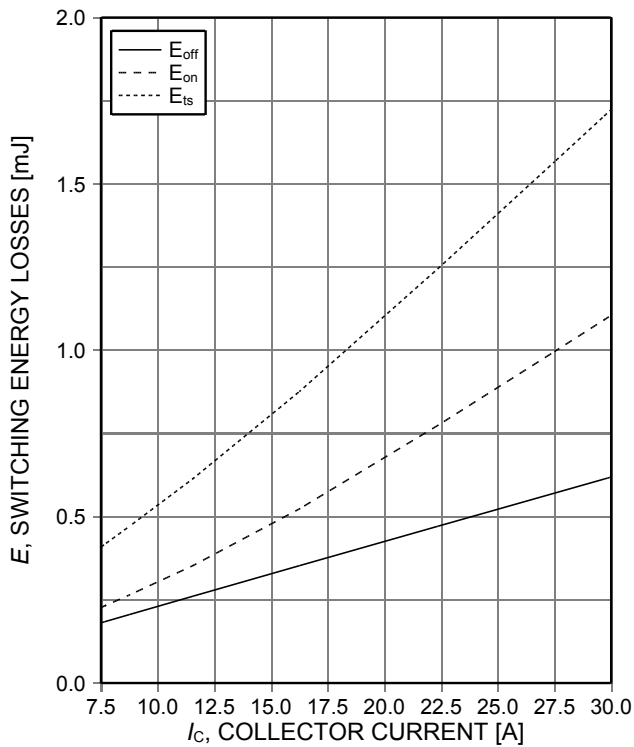


Figure 13. **Typical switching energy losses as a function of collector current**  
(inductive load,  $T_{vj}=175^{\circ}\text{C}$ ,  $V_{CE}=400\text{V}$ ,  $V_{GE}=15/0\text{V}$ ,  $r_G=15\Omega$ , Dynamic test circuit in Figure E)

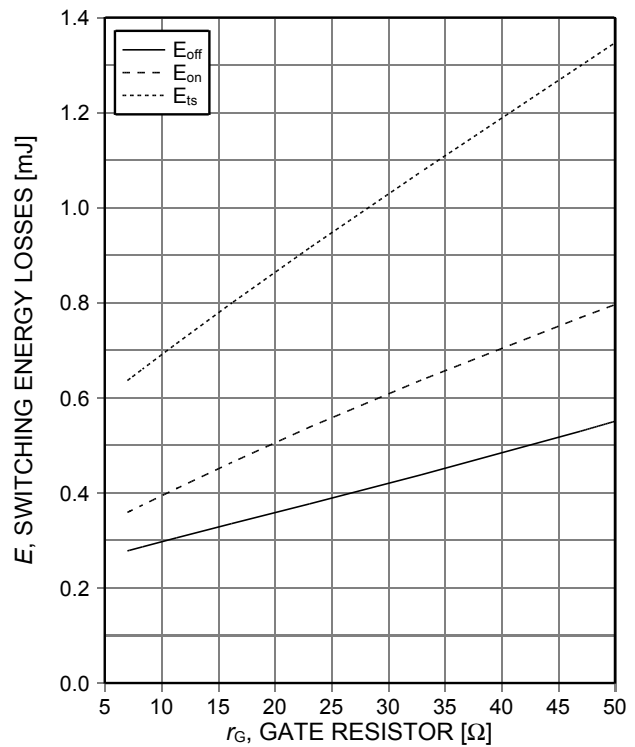


Figure 14. **Typical switching energy losses as a function of gate resistor**  
(inductive load,  $T_{vj}=175^{\circ}\text{C}$ ,  $V_{CE}=400\text{V}$ ,  $V_{GE}=15/0\text{V}$ ,  $I_C=15\text{A}$ , Dynamic test circuit in Figure E)

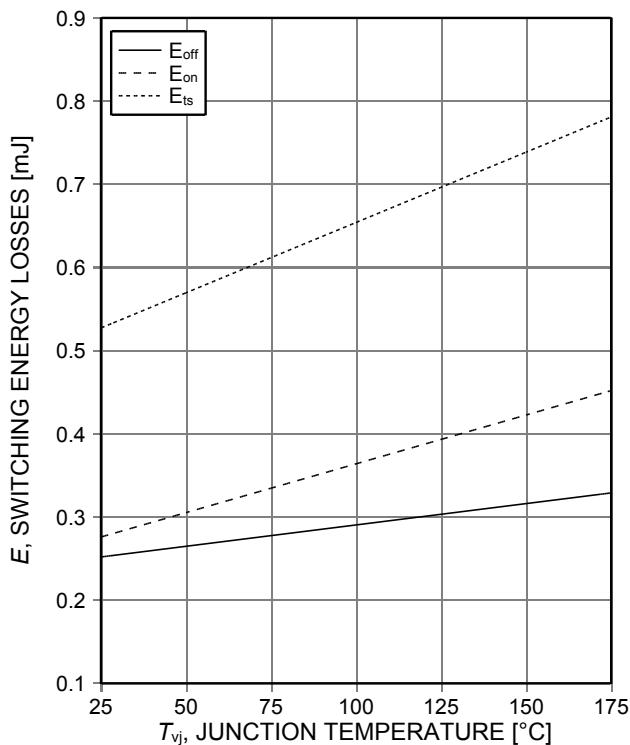


Figure 15. **Typical switching energy losses as a function of junction temperature**  
(inductive load,  $V_{CE}=400\text{V}$ ,  $V_{GE}=15/0\text{V}$ ,  $I_C=15\text{A}$ ,  $r_G=15\Omega$ , Dynamic test circuit in Figure E)

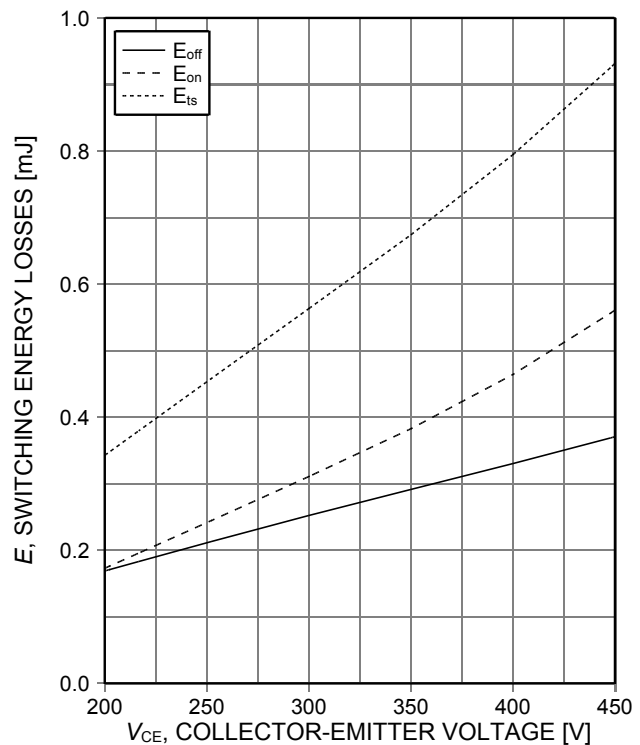


Figure 16. **Typical switching energy losses as a function of collector-emitter voltage**  
(inductive load,  $T_{vj}=175^{\circ}\text{C}$ ,  $V_{GE}=15/0\text{V}$ ,  $I_C=15\text{A}$ ,  $r_G=15\Omega$ , Dynamic test circuit in Figure E)

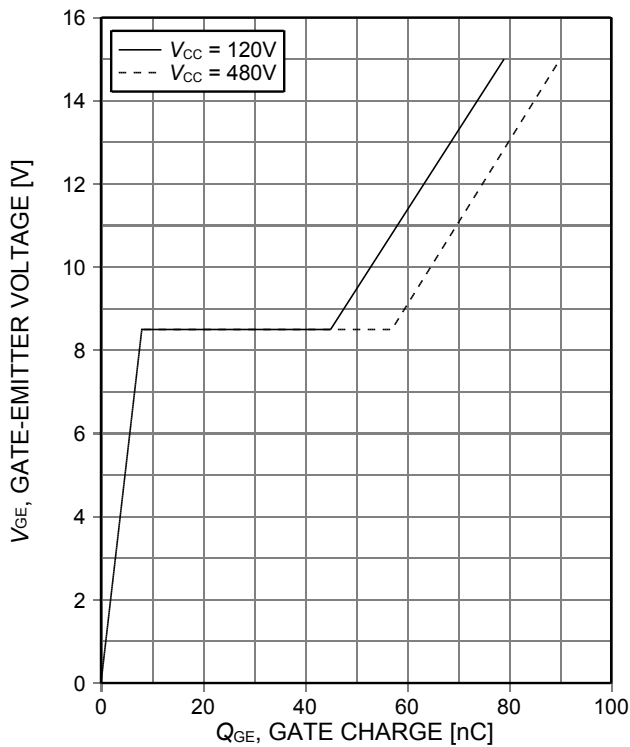


Figure 17. **Typical gate charge**  
( $I_C=15A$ )

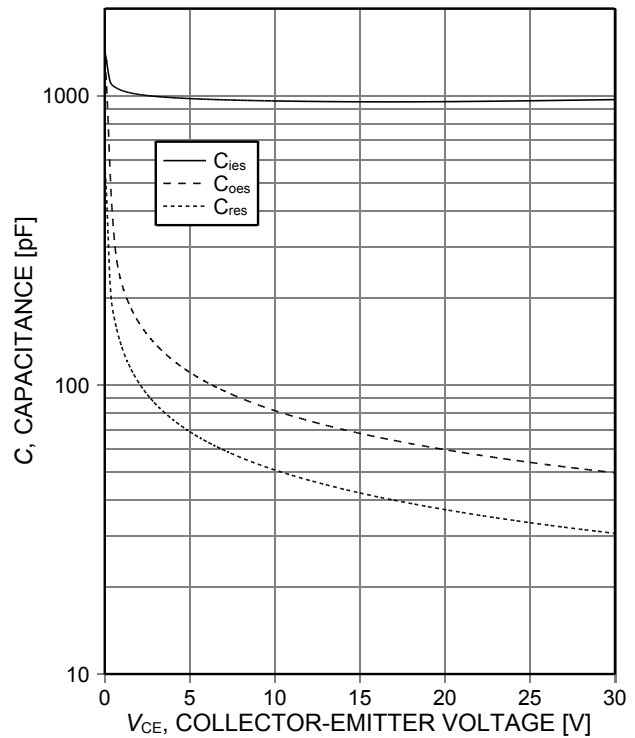


Figure 18. **Typical capacitance as a function of collector-emitter voltage**  
( $V_{GE}=0V$ ,  $f=1MHz$ )

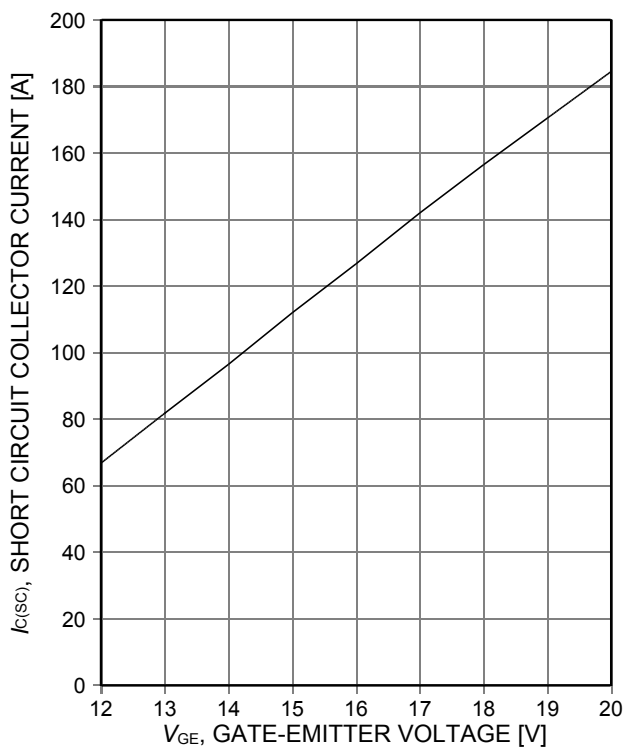


Figure 19. **Typical short circuit collector current as a function of gate-emitter voltage**  
( $V_{CE}\leq 400V$ , start at  $T_{vj}=25^\circ C$ )

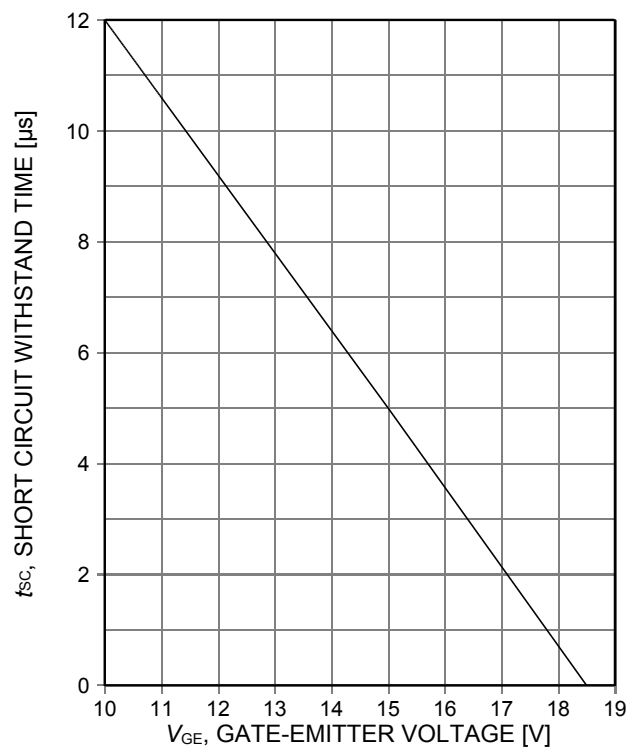


Figure 20. **Short circuit withstand time as a function of gate-emitter voltage**  
( $V_{CE}\leq 400V$ , start at  $T_{vj}=150^\circ C$ )

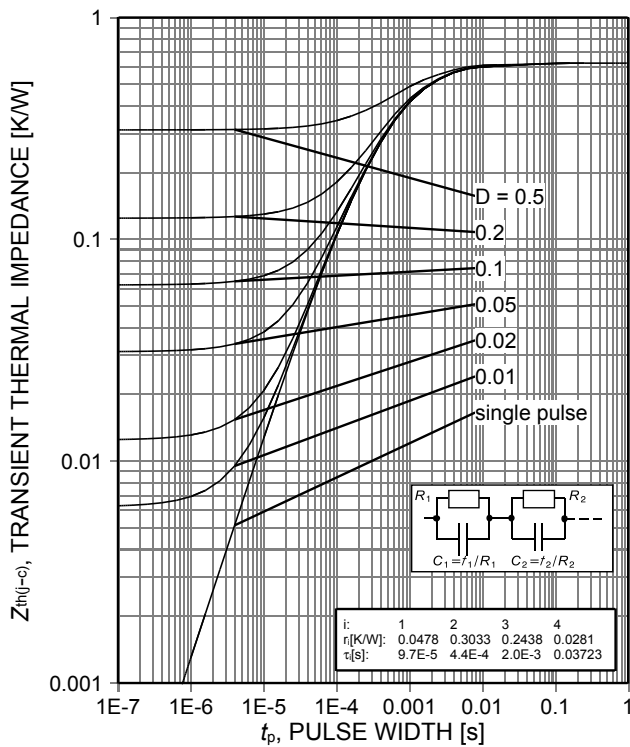


Figure 21. IGBT transient thermal impedance as a function of pulse width (see page 4<sup>3)</sup>)  
( $D=t_p/T$ )

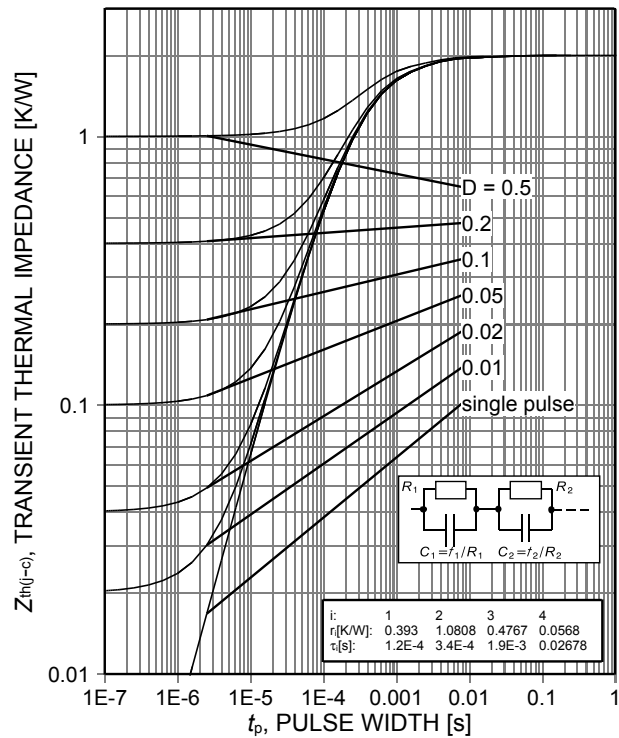


Figure 22. Diode transient thermal impedance as a function of pulse width (see page 4<sup>4)</sup>)  
( $D=t_p/T$ )

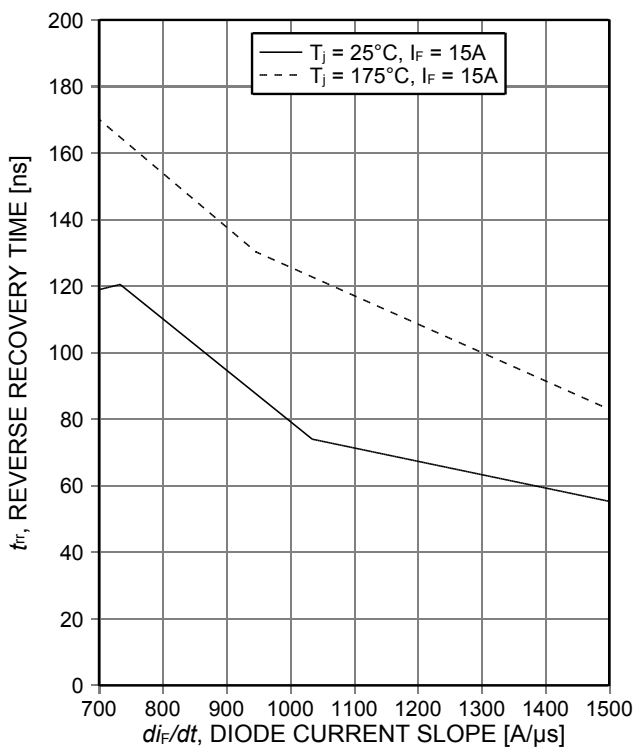


Figure 23. Typical reverse recovery time as a function of diode current slope  
( $V_R=400V$ )

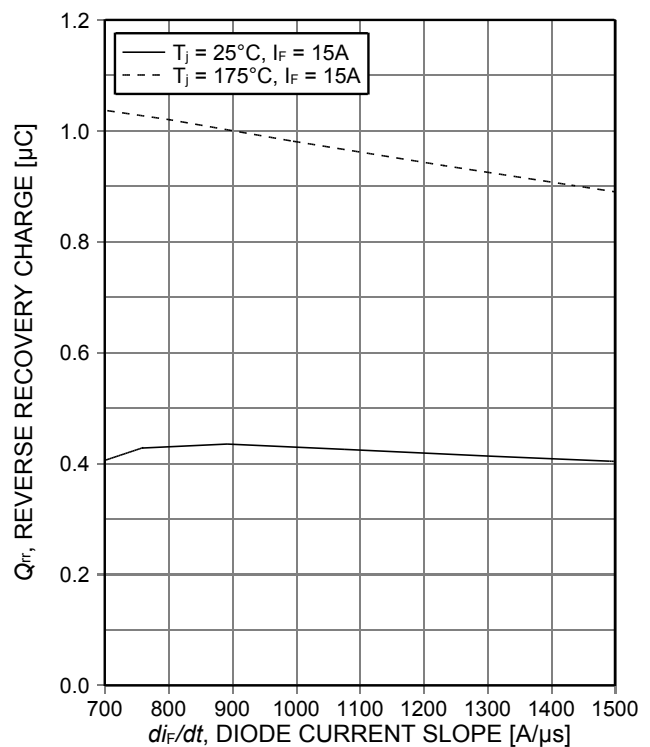


Figure 24. Typical reverse recovery charge as a function of diode current slope  
( $V_R=400V$ )

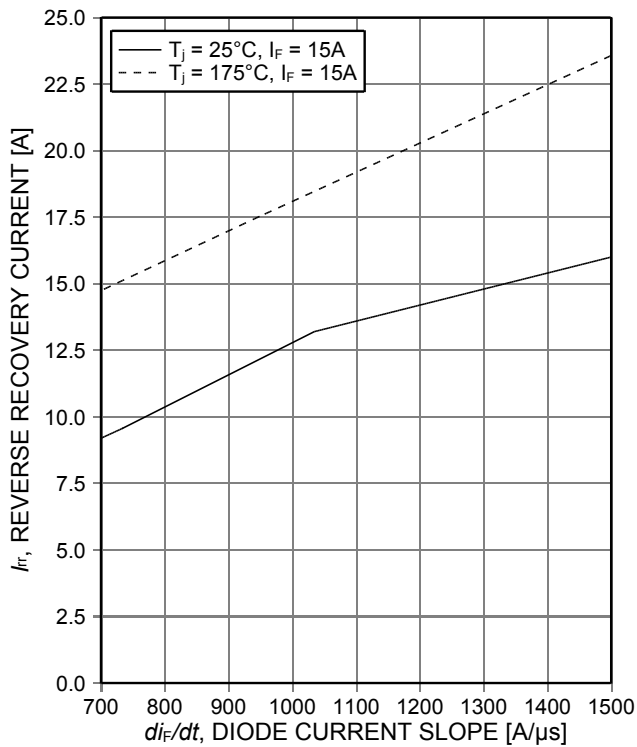


Figure 25. **Typical reverse recovery current as a function of diode current slope**  
( $V_R=400V$ )

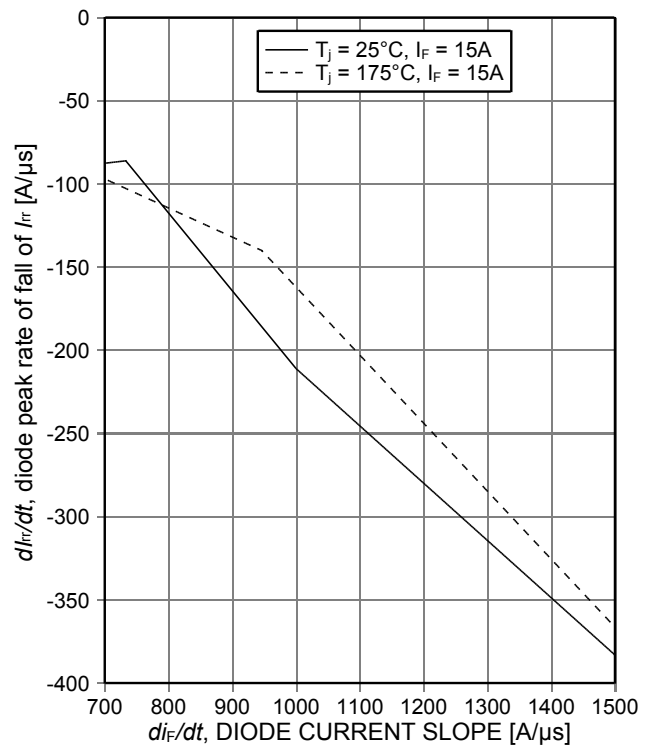


Figure 26. **Typical diode peak rate of fall of reverse recovery current as a function of diode current slope**  
( $V_R=400V$ )

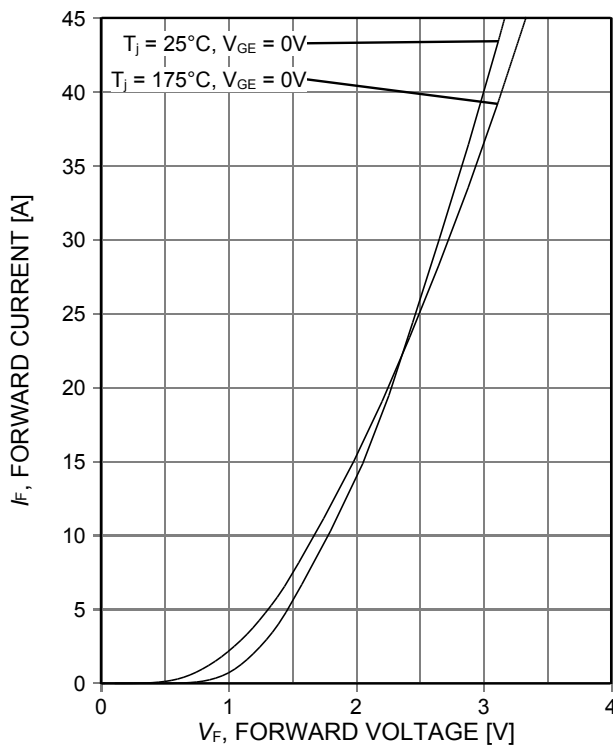


Figure 27. **Typical diode forward current as a function of forward voltage**

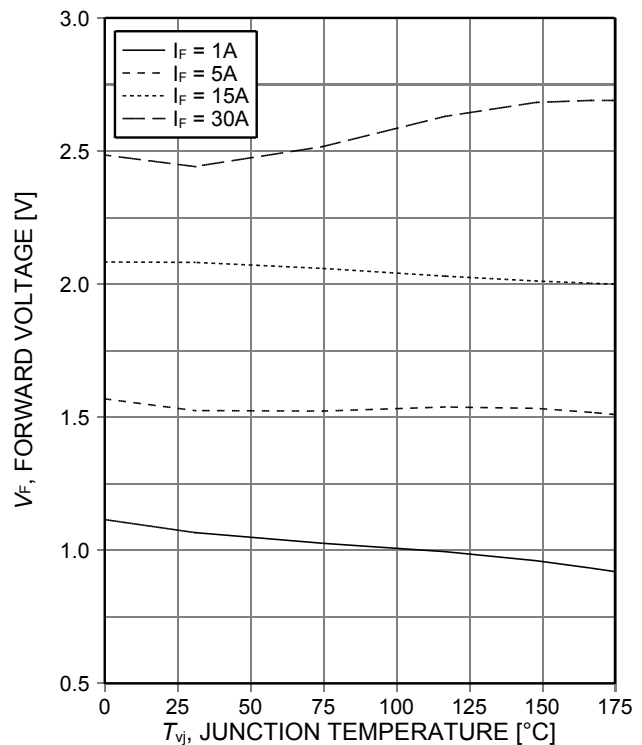
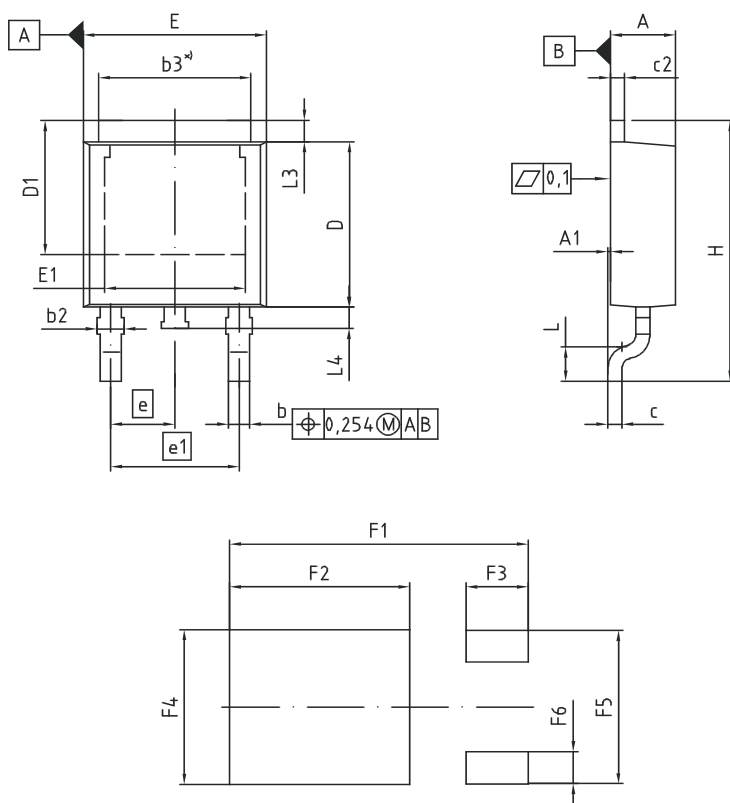


Figure 28. **Typical diode forward voltage as a function of junction temperature**

## PG-TO252 -3



\*) mold flash not included

| DIM | MILLIMETERS |       | INCHES      |       |
|-----|-------------|-------|-------------|-------|
|     | MIN         | MAX   | MIN         | MAX   |
| A   | 2.16        | 2.41  | 0.085       | 0.095 |
| A1  | 0.00        | 0.15  | 0.000       | 0.006 |
| b   | 0.64        | 0.89  | 0.025       | 0.035 |
| b2  | 0.65        | 1.15  | 0.026       | 0.045 |
| b3  | 5.00        | 5.50  | 0.197       | 0.217 |
| c   | 0.46        | 0.60  | 0.018       | 0.024 |
| c2  | 0.46        | 0.98  | 0.018       | 0.039 |
| D   | 5.97        | 6.22  | 0.235       | 0.245 |
| D1  | 5.02        | 5.84  | 0.198       | 0.230 |
| E   | 6.40        | 6.73  | 0.252       | 0.265 |
| E1  | 4.70        | 5.21  | 0.185       | 0.205 |
| e   | 2.29 (BSC)  |       | 0.090 (BSC) |       |
| e1  | 4.57        |       | 0.180       |       |
| N   | 3           |       | 3           |       |
| H   | 9.40        | 10.48 | 0.370       | 0.413 |
| L   | 1.18        | 1.70  | 0.046       | 0.067 |
| L3  | 0.90        | 1.25  | 0.035       | 0.049 |
| L4  | 0.51        | 1.00  | 0.020       | 0.039 |
| F1  | 10.60       |       | 0.417       |       |
| F2  | 6.40        |       | 0.252       |       |
| F3  | 2.20        |       | 0.087       |       |
| F4  | 5.80        |       | 0.228       |       |
| F5  | 5.76        |       | 0.227       |       |
| F6  | 1.20        |       | 0.047       |       |

|                                                                                                                     |
|---------------------------------------------------------------------------------------------------------------------|
| <b>DOCUMENT NO.</b><br>Z8B00003328                                                                                  |
| <b>SCALE</b><br>0 2.0 4mm                                                                                           |
| <b>EUROPEAN PROJECTION</b><br> |
| <b>ISSUE DATE</b><br>16-02-2011                                                                                     |
| <b>REVISION</b><br>04                                                                                               |

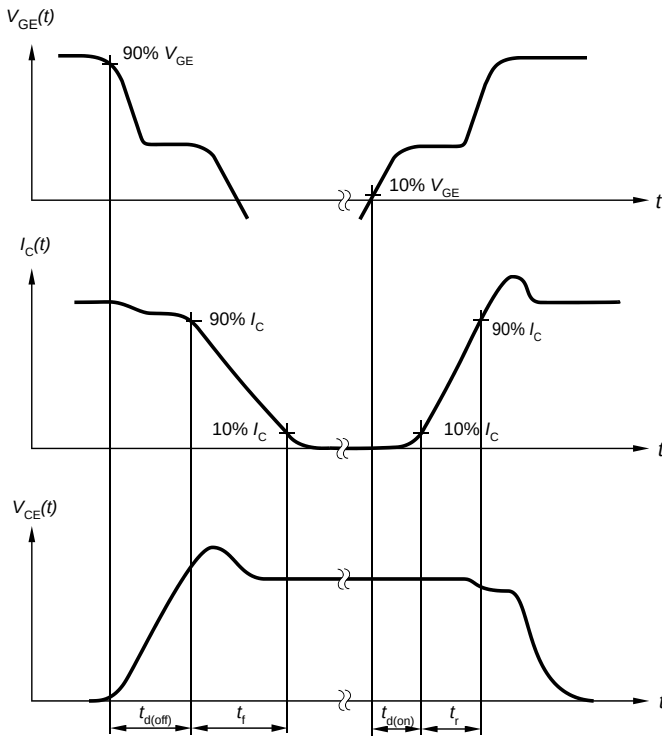


Figure A. Definition of switching times

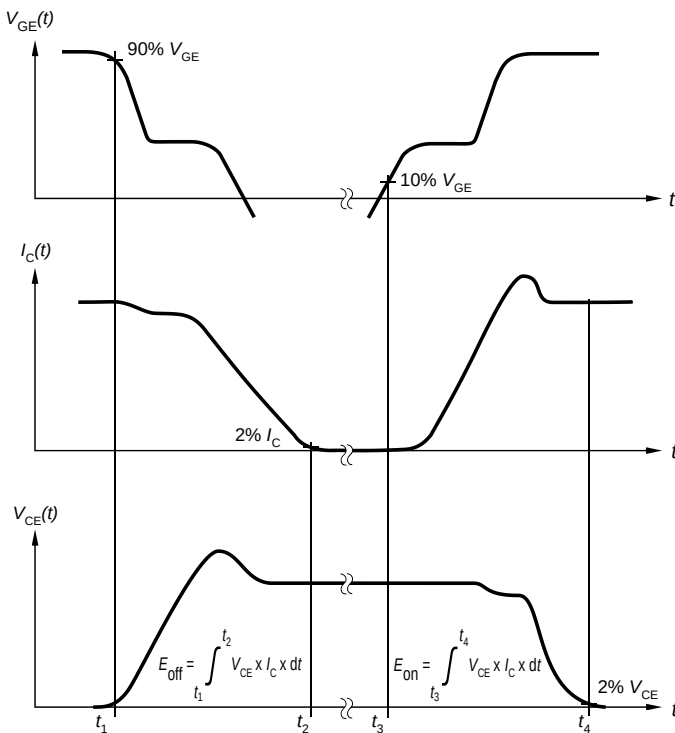


Figure B. Definition of switching losses

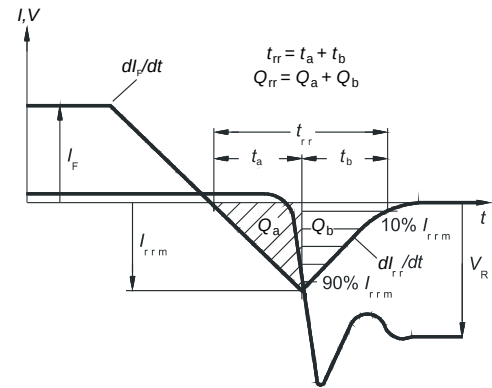


Figure C. Definition of diode switching characteristics

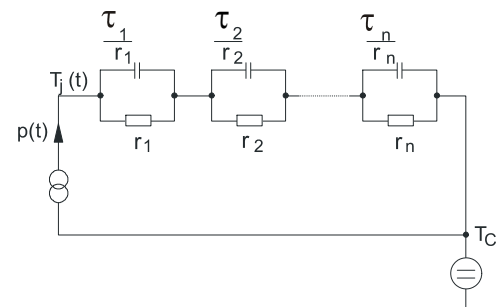
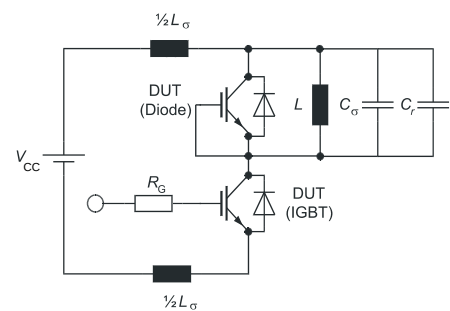


Figure D. Thermal equivalent circuit


Figure E. Dynamic test circuit  
Parasitic inductance  $L_{\sigma}$ ,  
parasitic capacitor  $C_{\sigma}$ ,  
relief capacitor  $C_r$ ,  
(only for ZVT switching)

## Revision History

IKD15N60RFA

Revision: 2014-12-15, Rev. 2.1

## Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.1      | 2014-12-15 | Final data sheet                             |

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